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Site-selectively generated photon emitters in monolayer MoS₂ via local helium ion irradiation

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Quantum light sources in solid-state systems are of major interest as a basic ingredient for integrated quantum photonic technologies. The ability to tailor quantum emitters via site-selective defect engineering is essential for realizing scalable architectures. However, a major difficulty is that defects need to be controllably positioned within the material. Here, we overcome this challenge by controllably irradiating monolayer MoS₂ using a sub-nm focused helium ion beam to deterministically create defects. Subsequent encapsulation of the ion exposed MoS₂ flake with high-quality hBN reveals spectrally narrow emission lines that produce photons in the visible spectral range. Based on ab-initio calculations we interpret these emission lines as stemming from the recombination of highly localized electron-hole complexes at defect states generated by the local helium ion exposure. Our approach to deterministically write optically active defect states in a single transition metal dichalcogenide layer provides a platform for realizing exotic many-body systems, including coupled single-photon sources and interacting exciton lattices that may allow the exploration of Hubbard physics.

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Point defects are important for a variety of physical phenomena in semiconductors. For example, they provide a means to engineer the equilibrium free-carrier density, they can serve as quantum emitters capable of hosting discrete quantum spin systems that can be optically addressed¹. A major challenge in several of these applications is that the defects need to be precisely positioned, which is particularly difficult for conventional three-dimensional semiconductors where defects are often buried deep within the bulk structure. One route to remedy this challenge is to reduce the physical dimensionality of the material. Over the last decade it became possible to fabricate and manipulate atomically thin two-dimensional (2D) materials that offer intriguing electronic and optoelectronic properties^{2,3}. In particular, the hexagonal transition metal dichalcogenides (TMDCs), such as MoS₂, MoSe₂, WS₂, and WSe₂, are excellent candidates for photonic applications due to their exceptionally strong light-matter interaction resulting from weak non-local dielectric screening^{4–6}. The strong Coulomb coupling manifests itself in an exciton dominated spectral response and very large exciton binding energies^{4,5,7–9}.

Beyond the response of mobile excitons, also quantum dot-like emission from localized excitons was recently demonstrated in WSe₂^{10–14}, GaSe¹⁵, MoSe₂¹⁶, and WS₂¹⁷ and the nature of the potential, which localizes the excitons is still not fully understood. The origin of such quantum emitters was hitherto considered to be caused by uncontrolled strain potentials that locally reduce the band gap, thus, funneling the recombination of excitons via a discrete recombination center^{17–20}. However, strain potentials are challenging to control, which limits the applicability of such quantum emitters for a prospective integration into quantum photonic circuits^{20–25}. In particular, scalable quantum technologies require the development of controlled approaches for the direct planar integration of quantum emitters with atomic scale resolution.

In this work, we propose and investigate an alternative route to engineer defect emitters that are of atomic scale. Specifically, we demonstrate theoretically and experimentally that localized defects in two-dimensional layers create trapping potentials in which bound complexes are formed that emit in a range of about hundred meV below the free exciton line in MoS₂. Our experimental approach to deterministically create such point defects involves site-selective helium ion exposure of small areas (100 × 100 nm) of atomically thin MoS₂. The precision with which defects are localized is expected to be solely limited by the resolution of the helium ion beam. Compared to strain engineering, a controlled exposure with helium ions is superior due to the sub-nm beam size that is very well suited to structure 2D materials at the nanometer scale²⁶. First attempts to generate optically active defects in TMDCs have been made by exposing the host crystal with α -particles²⁷ and helium ions²⁸. However, in these works a strong dynamical inhomogeneous linewidth broadening of ~40 meV was imposed on the emission due to the fluctuating environment. Here, we demonstrate that the encapsulation of helium irradiated MoS₂ monolayers with hBN allows one to define defect emitters with very narrow linewidths. The combination of ion exposure and subsequent encapsulation results in a hitherto unobserved new class of spatially localized and spectrally narrow defect emission in MoS₂ at very distinct energies on the order of ~100–220 meV below the neutral exciton, denoted by ${}^0X_{1s}^A$. Our spectroscopic observations are consistent with photon emission that stems from defect centers in MoS₂, which serve as highly localized exciton emission centers. The interpretation is corroborated by analyzing in detail the lineshape of the new emission peaks. This allows us to determine the interaction of the localized exciton with phonons, which indicates that the emitters are localized on a nanometer scale. Our study opens up new routes for inducing highly controllable defect emitters in

two-dimensional materials to create arrays of coupled single-photon sources¹, to study Anderson's orthogonality catastrophe^{29,30}, and to realize lattices of interacting excitons similarly to optical lattices for ultracold atomic gases³¹.

Results

Defect creation in a van der Waals heterostructure by helium ion irradiation. The van der Waals heterostructures studied in this work are iteratively stacked onto Si substrates covered with 290 nm thermally grown SiO₂. Onto this substrate we first transfer a multilayered hBN virtual substrate, and a single layer of MoS₂. Typical hBN thicknesses vary between ~10–30 nm as confirmed by atomic force microscopy. The samples are transferred into a helium ion microscope, and are site-selectively exposed to helium ions at a constant dose of $\sigma = 2.2 \times 10^{12} \text{ cm}^{-2}$, see Fig. 1a. Figure 1b shows a helium-ion microscope (HIM) image of the exposed van der Waals heterostructure. After the ion exposure, the entire MoS₂ crystal is fully encapsulated by another multilayer hBN capping using a dry viscoelastic transfer method.

We perform low-temperature μ -photoluminescence (μ -PL) spectroscopy on the samples in a helium flow cryostat at a lattice temperature of 10 K. For excitation, we use a cw laser with a photon energy of 2.33 eV and a low excitation power (power density) of less than 10 μW (0.884 kW cm⁻²). Figure 1c shows the spatially resolved and spectrally integrated μ -PL response of a typical sample as a false color representation. Representative luminescence spectra from five randomly selected positions of the exposed sample that show defect emission are presented in the bottom of Fig. 1d and compared to a spectrum of a pristine (unexposed) sample. All spectra reveal spectrally narrow neutral exciton ${}^0X_{1s}^A$ ($FWHM = (8.3 \pm 2.5) \text{ meV}$) and charged exciton ${}^-X_{1s}^A$ ($FWHM = (9.4 \pm 2.9) \text{ meV}$) emission whose inhomogeneous linewidth is reduced due to the encapsulation with hBN^{6,32–34}. Remarkably, for the helium ion exposed samples in addition to the delocalized excitons, we observe spectrally sharper emission peaks X_L ($FWHM \sim 0.5\text{--}6 \text{ meV}$) in a window of $\Delta E_L \sim 100\text{--}220 \text{ meV}$ red-shifted from ${}^0X_{1s}^A$ (spectral range highlighted by a dotted box in Fig. 1d). These features are superimposed on the so-called L-peak that is observed in monolayer MoS₂^{4,5,35} and has recently been attributed to the presence of sulphur vacancies^{36,37}. The sharp spectral features are spatially localized and require helium ion exposure of MoS₂ and the subsequent encapsulation with hBN. Spectrally sharp peaks do not occur in unexposed hBN/MoS₂/hBN heterostacks (cf. bottom spectrum in Fig. 1d), neither in exposed MoS₂ without hBN encapsulation nor in exposed hBN (See Supplementary Fig. 1).

To obtain further information on the origin of the sharp spectral emission, we statistically evaluate the energetic detuning $\Delta E_L = E({}^0X_{1s}^A) - E(X_L)$ of each localized emission peak $E(X_L)$ with respect to $E({}^0X_{1s}^A)$. Figure 1d, top, shows a histogram of the localized X_L emission energies as a function of detuning ΔE_L for ~3500 emitters for one representative sample (See Supplementary Fig. 5).

The histogram shows that the spectral emitters possess a continuum of energies in the range of $\Delta E_L \sim 100\text{--}220 \text{ meV}$ below the neutral exciton. Intriguingly, we consistently observe that most of the helium ion induced emission peaks emit in a spectrally narrow (15) distribution at $\Delta E_L \sim 193 \text{ meV}$ (also See Supplementary Figs 4 and 5).

We also show the spatial occurrence of emitters in three energy bins (cf. arrows in Fig. 1d), overlaid in Fig. 1c. So far, single-photon emitters have been found at sample edges or folds, where the bandstructure is strongly influenced by the crystal boundary, coupling of atomic-orbitals by local symmetry breaking or strain¹. By contrast, we find spectrally sharp emitters homogeneously

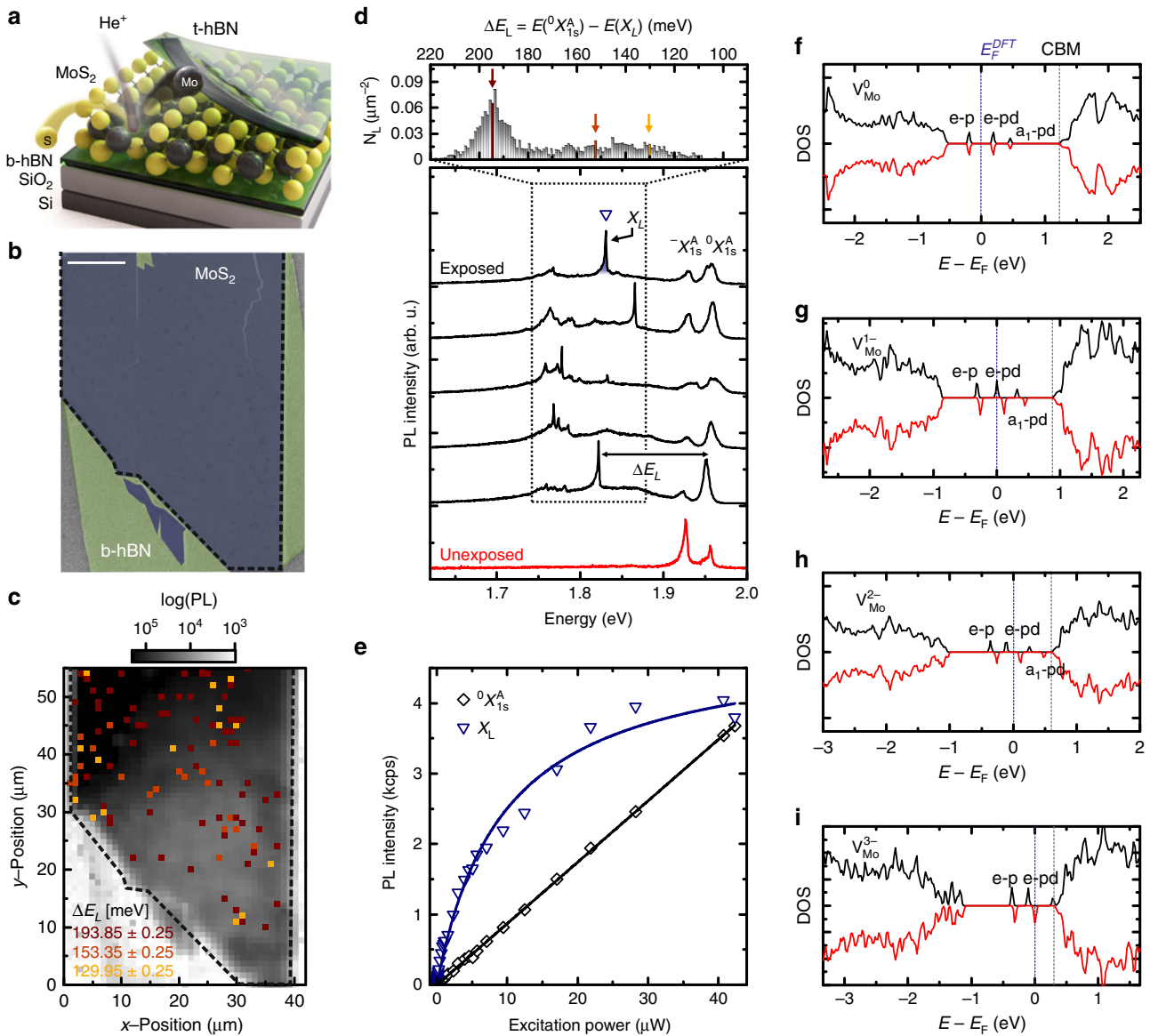


Fig. 1 Deterministically induced defect emitters in atomically thin MoS₂ realized by focused helium ions. **a** Schematic illustration of the exposed MoS₂/hBN van der Waals heterostructure. **b** Helium ion microscopy image taken at a dose of $\sigma = 2.2 \cdot 10^{12} \text{ cm}^{-2}$. The scale bar is 10 μm . **c** Spatially resolved and spectrally integrated photoluminescence mapping. The colored pixels depict the occurrence of emitters within 500 μeV wide energy bins (highlighted by colored arrows in **d**). **d** Bottom panel: typical low-temperature (10 K) $\mu\text{-PL}$ spectra of the exposed (black) and unexposed (red) hBN/MoS₂/hBN heterostructure. The spectra of exposed MoS₂ feature emission from mobile excitons ${}^0X_{1s}^A$ and trions ${}^{-}X_{1s}^A$, as well as single emission lines X_L (open triangle) at lower energies. Top panel: a histogram of the emission energies detuned by $\Delta E_L = E({}^0X_{1s}^A) - E(X_L)$ below ${}^0X_{1s}^A$. **e** Power dependence: ${}^0X_{1s}^A$ shows an expected linear power dependence, while the X_L emission saturates for higher excitation powers (data for the emitter highlighted by open triangle in **d**). **f-i** DFT calculated spin-up (black) and spin-down (red) density of states (DOS) of the neutral V_{Mo}^0 , single negatively V_{Mo}^{1-} , double negatively V_{Mo}^{2-} , and triple negatively charged V_{Mo}^{3-} molybdenum vacancy. The DOS of V_{Mo}^0 shows doublet $e-p$, $e-pd$ and singlet a_1-pd defect states inside the band gap. The a_1-p singlet state is situated within the valence band. The more electrons are added to the vacancy the closer the defect states and the DFT computed Fermi level energy E_F^{DFT} shift to the conduction band minimum (CBM) because of the on-site Coulomb repulsion

distributed all over the 2D sample; this is a direct consequence of the helium ion exposure.

The sharp emission lines reveal a saturating behavior with a threshold power of $P_{sat} \sim 10 \mu\text{W}$ (cf. Figure 1e), which is consistent with saturating a finite density of a single defect state as fitted by

$$I \propto \frac{P}{P + P_{sat}} \tag{1}$$

By contrast, the 2D neutral exciton ${}^0X_{1s}^A$ shows the expected linear dependence with the excitation power. MoS₂ exhibits

several defects, most prominently single sulfur vacancies and single molybdenum vacancies^{38–40}. So far, sulphur vacancies have not been demonstrated to be optically active, because they are very likely to be passivated with oxygen⁴¹, although they are ubiquitous in exfoliated, unexposed MoS₂³⁷. Here, we concentrate on molybdenum vacancies V_{Mo} , although we are aware that the discussed defect emitters might be of character that is more complex. Figure 1f–i show the ab-initio calculated density of states (DOS) for a neutral V_{Mo}^0 , as well as a single, double and triple negatively charged molybdenum vacancy (V_{Mo}^{1-} , V_{Mo}^{2-} , and V_{Mo}^{3-}). The vacancy states have a trigonal and mirror symmetry

between the two layers of the sulphur and the molybdenum layer⁴⁰. In turn, two singlet (a_1) and two doublet (e) states are expected for all cases. The lowest a_1 - p [e - p] level stems from the six adjacent sulphur p orbitals, and are found inside [above] the valence bands. The e - pd and a_1 - pd states originate from the hybridization of the six sulphur p and six (second nearest neighbour) molybdenum d orbitals and are situated in the gap⁴⁰. We find that all presented states are stable and relaxed within our DFT framework. Since ΔE_L is significantly smaller than the quasi particle band gap in MoS₂, we assume that the Fermi energy is close to the conduction band minimum (CBM). We interpret the experimentally observed sharp emission lines as resulting from excitons that also involve particle-hole excitations from the defect state orbitals⁴².

Figure 1f–i demonstrates that for instance, for V_{Mo}^{2-} and V_{Mo}^{3-} , the DFT computed Fermi energy E_F^{DFT} is consistently close to the CBM. Taking the computed energy differences between each state and the CBM, our ab-initio calculation suggests that in this interpretation, the lowest unoccupied state in the V_{Mo}^{3-} , the e - pd state, is likely to be involved in the photoluminescence signal X_L as in Fig. 1d (cf. Supplementary Figs 5 and 9). In particular, the computed energy difference $\Delta E^{DFT} = E(CBM)^{DFT} - E(e-pd)^{DFT} = 0.22$ eV coincides with the highest experimental detuning ΔE_L in the top panel of Fig. 1d. However, the DFT calculation does not consider the binding energy of the exciton that is comprised of the different electronic orbitals with a complex distribution of weights and varying momentum dependencies⁴².

Site-selective creation of optically active defects by local helium ion irradiation. In order to demonstrate the site-selective nature of our approach, we write a matrix of 100×100 nm fields with a pitch of $2 \mu\text{m}$ onto monolayer MoS₂ that is deposited on hBN. An optical micrograph of the flake prior to exposure is presented in Fig. 2a. Subsequent to exposure, the nano-structured MoS₂ monolayer is fully encapsulated in hBN. We record a spatially resolved PL mapping of the treated areas with a small step size (250 nm). The corresponding spatially resolved and spectrally integrated PL mapping is presented in Fig. 2b (grayscale). Here, an integration range of $\Delta E = (193 \pm 5)$ meV is chosen since, statistically (cf. Figure 1d), the localized emission is the strongest at these energies. Enhanced PL emission is clearly observed at the irradiated spots. Moreover, from the data, we extract and overlay the occurrence of localized emission X_L with the PL mapping (highlighted in orange). We find that localized emission is activated at all positions that are exposed by the HIM. Conversely, sharp line emission is not observed from the unexposed regions. Corresponding spectra of five exposed positions are presented in Fig. 2c. Each spectrum exhibits a small number (1–3) of emission lines that are completely absent in unexposed areas (cf. black spectra in Fig. 2c). Importantly, the site-selectively created defect emitters exhibit emission at $\Delta E \sim 193$ meV in agreement with the distribution obtained from statistics in Fig. 1d (also See Supplementary Fig. 5). Since no annealing step is needed for emitter creation, the writing accuracy is expected to be predominantly limited by the helium ion beam, and is, therefore expected to be on the nanometer scale. Near-field optical techniques and scanning tunneling microscopy can further be used to ultimately reveal the writing accuracy of atomistic defect states in the monolayer MoS₂.

Photoluminescence excitation spectroscopy and time stability of an individual single defect emitter. To further corroborate the above interpretation of optically active defects, we perform photoluminescence excitation (PLE) spectroscopy to probe the energetic structure of the involved states. Figure 3a presents a

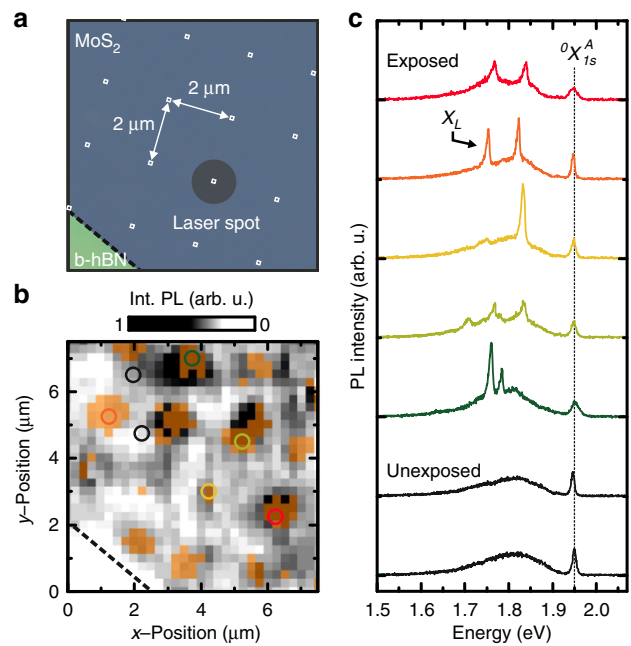


Fig. 2 Site-selective generation of defect emission by helium ion exposure. **a** Optical micrograph of the monolayer MoS₂/hBN van der Waals heterostructure prior to helium ion exposure and full encapsulation. A matrix of 100×100 nm fields is exposed with a pitch of $2 \mu\text{m}$. A dose of $\sigma = 2.2 \times 10^{12} \text{ cm}^{-2}$ is used. **b** Corresponding spatially resolved and spectrally integrated PL mapping (grayscale) at 10 K. Spectra are integrated for $\Delta E = (193 \pm 5)$ meV. The spatial occurrence of emitters in the range $\Delta E_L \sim 100$ – 220 meV is overlaid in orange. **c** Selected spectra taken from **b** are shown. All spectra reveal emission from ${}^0X_{1s}^A$ while only irradiated areas reveal emission from localized states X_L . The defect emission is absent in unexposed areas (black spectra and corresponding circles in **b**)

false color plot for a typical PLE scan of an emission line X_L as the excitation energy is tuned across the ${}^0X_{1s}^A$. The emission occurs at $E(X_L) = (1.76 \pm 0.01)$ eV energetically well below the ${}^0X_{1s}^A$. When measuring differential reflectivity $\Delta R/R$ using a broadband supercontinuum source, we identify ${}^0X_{1s}^A$ at an energy of $E({}^0X_{1s}^A) = 1.95$ eV (cf. Figure 3b). Upon resonant excitation of ${}^0X_{1s}^A$, the X_L emission is significantly increased. This is a consequence of the efficient creation of excitons, when the laser energy is on resonance with an exciton transition (See Supplementary Fig. 7 for excitation on ${}^0X_{2s}^A$ and ${}^0X_{1s}^B$). Most significantly, we can excite X_L states also below the free exciton transitions. This is consistent with recently predicted absorbance spectra of single vacancy defects in 2D materials⁴² and in contrast to strain induced quantum dot-like emitters^{10–15,17–20}.

Another key property of photonic emitters is their spectral stability. A representative time trace of a defect emitter is presented in Fig. 3c (with a spectrum acquired every second). Examples of two spectra highlighted in Fig. 3c are plotted in Fig. 3d. They demonstrate that the emitter exhibits a blinking behavior. This is an observed feature of various types of few-level systems⁴³. In our case, the blinking behavior is not surprising since the defects are embedded in a two-dimensional plane with large surface-to-volume ratio and charges in the environment that are very likely to randomly fluctuate in position and time.

Defect-phonon interaction and the independent boson model. Measuring the temperature dependence of the μ -PL spectra

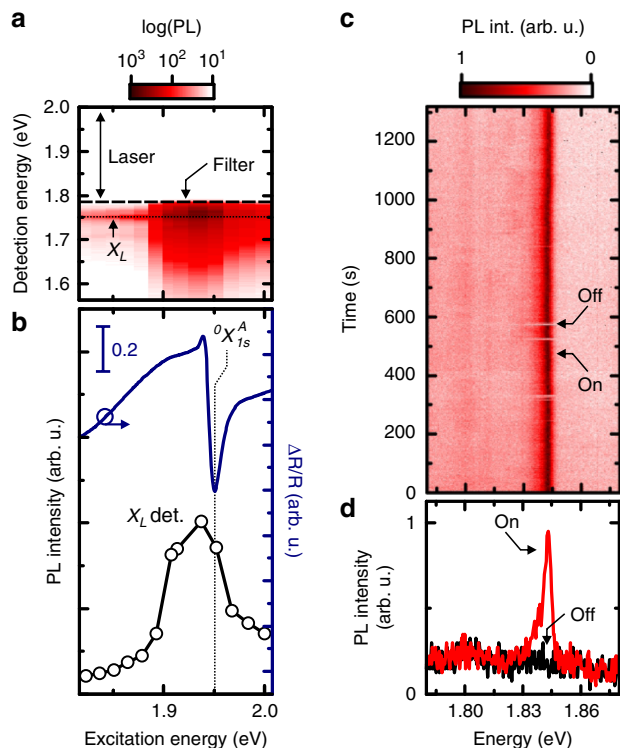


Fig. 3 PL excitation spectroscopy and time stability of optically active defect emitters. **a** False color plot showing the localized emission X_L for the excitation being tuned across ${}^0X_{1s}^A$. **b** The differential reflectivity $\Delta R/R$ of the heterostructure reveals the X_{1s}^A as highlighted by the dashed line. The reflectivity is compared to the PL intensity of the X_L as a function of laser excitation energy. **c** Time trace of the photoluminescence emission of a defect emitter recorded over long times. The integration time is set to 1 s while spectra are acquired every second. **d** Two exemplary spectra taken from **c** for the emitter being switched on and off

allows us to determine the interactions between the involved electron orbitals and phonons. We gradually change the lattice temperature from 10 K to 300 K while recording μ -PL spectra (cf. Figure 4a). The spectra reveal emission from the defect emitters that are strongly red-shifted and simultaneously broadened at elevated temperatures (similar as for the ${}^0X_{1s}^A$). We analyze the evolution of the emitter X_L in detail by utilizing the independent boson model that has been successfully applied to the lineshape analysis of quantum dot states^{44–46} and defect-bound excitons⁴⁷. Figure 4b highlights the spectra of X_L for selected temperatures with lineshapes fitted by this model (red lines). In particular, the lineshape of each emitter is found to exhibit a very pronounced acoustic phonon sideband (~ 10 meV) at the low energy side. Most likely, this low energy tail results from interaction with a specific bandwidth of acoustic phonons since the defects are highly localized in real space⁴². Our model particularly accounts for the coupling with LA/TA phonon branches, while coupling with the ZA branch is found to be negligible. For low temperatures, we find the best agreement of the calculated lineshape with our data for an effective Bohr radius of $a_B = 2$ nm. Taking into account a theoretical phonon lifetime of $\frac{1}{\gamma_{ph}} \sim 40$ ps⁴⁸, we obtain an excitonic radiative lifetime (linewidth) of ~ 1 ps (~ 0.5 meV). The lineshape in Fig. 4b is most asymmetric at low temperatures where phonon emission is more likely to happen than phonon absorption while for higher temperatures, the lineshape becomes more symmetric. Moreover, the PL emission reduces in intensity at elevated temperatures with the defect emitters typically

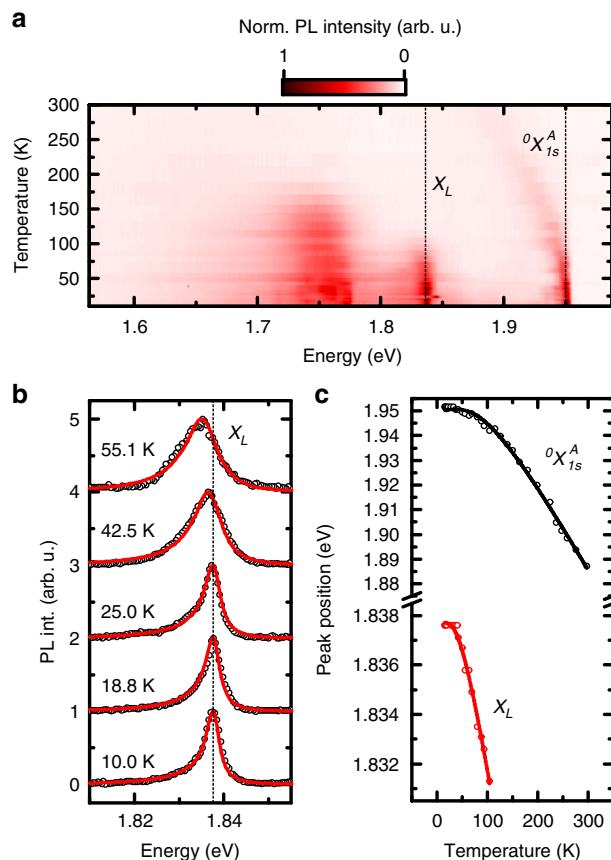


Fig. 4 Temperature-dependent PL spectroscopy of a single emission line X_L and independent boson model. **a** False color plot of the temperature-dependent evolution of PL from localized and delocalized excitons. The emission energies of neutral exciton ${}^0X_{1s}^A$ and one defect emitter X_L at 10 K are highlighted with a dashed line, respectively. **b** Temperature-dependent spectra of X_L fitted with an independent boson model. Best agreement is found for $a_B = 2$ nm. **c** Temperature-dependent peak position of ${}^0X_{1s}^A$ and X_L . Data are fitted with Eq. (2)

exhibiting activation energies that are far below $k_B T$ (See Supplementary Fig. 10).

The temperature-dependent peak positions in Fig. 4a manifest in a polaron shift for all spectral features (cf. Figure 4c), as phenomenologically described by⁴⁹

$$E_G(T) = E_G(0) - S\langle\hbar\omega\rangle \left[\coth\left(\frac{\hbar\omega}{2k_B T}\right) - 1 \right], \quad (2)$$

with the emission energy $E_G(0)$ at 0 K, the Huang–Rhys factor S , the average phonon energy $\langle\hbar\omega\rangle$, and the Boltzmann constant k_B . Fitting X_L in Fig. 4c reveals average phonon energies of $\langle\hbar\omega\rangle = (12.69 \pm 1.17)$ meV and an electron–phonon coupling of $S = 0.791 \pm 0.071$ (for ${}^0X_{1s}^A$: $\langle\hbar\omega\rangle = (25.11 \pm 1.02)$ meV and $S = 2.135 \pm 0.061$). The experimentally observed value of $S_{exp} = 0.791$ is in very good agreement with $S_{theory} = 0.75$ as obtained from the independent boson model (See Supplementary Fig. 12). From our model, we can also distinguish between the fraction of photons emitted by the zero phonon line (ZPL) and the phonon sideband (PSB). Taking the relative spectral weight of ZPL and PSB, we find a Debye–Waller factor of ~ 0.2 at 10 K, comparable to other few-level systems⁵⁰.

Discussion

To start the discussion, we point out that the emission peaks occur homogeneously across the whole basal plane of the

exposed MoS₂ encapsulated into hBN (cf. Figure 1c). The sharp peaks neither occur in exposed hBN without MoS₂ nor in unexposed hBN/MoS₂/hBN (See Supplementary Fig. 1). This phenomenology suggests that the optically active defects can probably not be explained by sulphur vacancies, because the latter are ubiquitous in exfoliated, unexposed MoS₂³⁷, although they are very likely to be produced under helium ion exposure as well^{28,38,40}. However, sulphur vacancies are easily passivated by oxygen⁴¹, which especially applies to the discussed nano-fabricated TMDCs under ambient conditions. Figure 2b, c support this interpretation, since the emission X_L only appears at the exposed areas, while the unexposed areas show the broad L-peak attributed to the presence of sulphur vacancies^{36,37}. Equally, quantum emitters in hBN can be excluded for our sample (See Supplementary Figs 1 and 8)⁵¹. Intriguingly, the beam energy of the HIM (30 keV) and also the excess energy of the secondary electrons (<10 eV) produced in the exposed materials are sufficient to form defects with a large formation energy, such as molybdenum vacancies^{40,52}, that are rare in pristine samples^{37,39}. This argument could explain why we observe optically active defect sites only after the helium ion exposure of the MoS₂ monolayers.

In our understanding, the influence of hBN is two-fold. On the one hand, the emission peaks X_L have the lowest emission energy of ΔE_L of ~193 meV below ${}^0X_{1s}^A$. Encapsulated in hBN, the excitonic emission energy is renormalized due to the dielectric environment⁶. On the other hand, the emission linewidth is strongly reduced for both X_L and ${}^0X_{1s}^A$ ^{6,32–34}. The combination of the hBN-effects explain the sharp spectral features, which are spread across the broad energy window $\Delta E_L \sim 100$ –220 meV in Fig. 1d. However, most of the defects emit at an energy detuning of ~193 meV, which resembles the spectrally broad PL emission of helium ion exposed MoS₂ on SiO₂/Si substrate²⁸ and on hBN (See Supplementary Fig. 2). This observation is also in good agreement with the emission properties of site-selectively activated defects in Fig. 2. From our consistent observations, we draw the conclusion that most of the emission indeed originates from the same helium ion induced defect that is deterministically created at designated positions in the MoS₂ monolayer. The defect emission at smaller detunings $\Delta E_L < 180$ meV is most likely caused by dielectric effects, adsorbates or simply by another type of defect.

For all possibly created defects, the emission at ΔE_L of ~193 meV must resemble the lowest unoccupied, optically active state. This interpretation is consistent with the saturating behavior as in Fig. 1e, and it also explains the blinking behavior in Fig. 3c, d. Furthermore, the PLE measurements in Fig. 3a are also consistent with this interpretation, since the expected joint density of states of localized electron orbitals at the defect and its environment sum up to a finite, continuous absorbance from the lowest unoccupied state (i.e., at ΔE_L of ~193 meV) up to ${}^0X_{1s}^A$ ⁴². The excitation laser creates electrons that can occupy the defect states followed by optical recombination with a valence band hole and possible further local defect orbitals⁴².

We would like to note that there are few possible defects in MoS₂, from the already mentioned sulphur and molybdenum vacancies to interstitials and defect complexes involving more than one atom.^{38–40} For the sake of clarity, we concentrate on V_{Mo} . Our DFT calculation in Fig. 1 neglects the momentum dependence of the involved electron states and variable binding energies per orbital⁴². In our experiment, the influence of ambient gases might have further effects²⁸. Taking the argument of refs. ^{40,42}, the complex admixture of *p*- and *d*-orbitals in the molybdenum defect (cf. Figure 1f–i) give rise to a continuous absorbance below ${}^0X_{1s}^A$, as recently discussed for single chalcogen vacancies^{40,42}.

Figure 4b demonstrates that the effective exciton–phonon interaction can be described by the independent boson model,

which suggests that the effective interaction length is localized within only ~2 nm. The independent boson model further suggests an excitonic lifetime of only 1 ps (See Supplementary Fig. 12). This theoretical value is a lower bound for the actual lifetime because we omit other sources of broadening mechanisms. Experimentally, we determine the upper bound of the radiative lifetime to be <150 ps (limited by the instrument response function), which renders second order time-correlation measurements of $g^{(2)}$ challenging. This experimental observation is in stark contrast to strain induced quantum dot-like emitters in TMDCs with nanosecond lifetimes based on an effective type-II band alignment^{10–14}. Different excitation conditions in gated devices that could suppress the L-peak emission may enable to access the photon statistics and unambiguously proof the quantum nature of the defect emission.

In conclusion, we have demonstrated a method to deterministically and site-selectively generate optically active defects in MoS₂. The superior optical quality resulting from hBN encapsulation reveals spectrally narrow emission at very distinct detunings with respect to the neutral exciton. The emission lines show a saturating power dependence and a blinking behavior. On a broader perspective, a controlled production of optically active defects in a periodic pattern using helium ion beam exposure may allow the exploration of exotic many-body physics in lattice systems, including the demonstration of coupled photon sources¹, the Anderson orthogonality catastrophe^{29,30}, as well as the Mott transition between a superfluid and an insulator³¹ in the presence of dissipation. The site-selective approach for writing optically active defects with high accuracy and ease at designated positions is expected to be highly beneficial for integration into photonic circuits. Moreover, the inherent proximity of the engineered defect states to surfaces opens exciting ways for possibly harnessing them as local nanometer scale sensors, investigating nuclear spin physics with wave functions only sampling a fraction of atoms or studying screening physics in the ultimate limit of a localized electronic defect state.

Methods

Sample structure. We employed the viscoelastic transfer method to transfer MoS₂ monolayer crystals and hBN multilayers onto 290 nm SiO₂ substrates. The MoS₂ crystals used for exfoliation were purchased from SPI Supplies while high-quality hBN bulk crystals were provided by Takashi Taniguchi and Kenji Watanabe from NIMS, Japan.

Helium ion microscopy. We used MoS₂ monolayers transferred onto hBN/SiO₂/Si substrates for He⁺ irradiation. For the data shown in Fig. 1, a beam current $I \sim 1$ pA and a beam energy of 30 keV are used. Large areas are exposed with a beam spacing of 5 nm. The dwell time was adjusted such that a dose of $\sim 10^{12}$ He⁺ cm⁻² is obtained, which is optimized for a high density of defect emitters (See Supplementary Fig. 6).

For the data shown in Fig. 2, a low beam current of $I \sim 20$ fA is used in order to obtain a low helium ion dose of $\sim 10^{12}$ He⁺ cm⁻² by accordingly adjusting the dwell time. Small areas of 100 × 100 nm are exposed. A beam spacing of 0.5 nm is used.

Optical spectroscopy. Confocal optical spectroscopy was performed in a helium flow cryostat with the sample kept at a lattice temperature of ~10 K. For cw μ -PL experiments in Fig. 1, we used a doubled Nd:YAG laser with an excitation energy of 2.33 eV and typical excitation powers of less than 10 μ W, which results in an excitation power density of 0.884 kW cm⁻² at a laser spot diameter of 1.2 μ m.

The μ -PL data in Fig. 2a are recorded with an excitation energy of 2.54 eV and an excitation power (density) of 900 nW (0.058 kW cm⁻²) with a laser spot diameter of 0.7 μ m.

For measuring differential reflectivity spectra a supercontinuum white light source was used that was focused with an optical microscope onto the sample kept at a lattice temperature of ~10 K with a spot size of ~1–2 μ m.

For PLE experiments, we used an optical parametric oscillator (OPO) pumped with a Ti:Sa at 820 nm with a repetition rate of 80 MHz and a 150 fs pulse width. For our measurements, we used the signal output of the OPO, which was incrementally tuned in steps of ~25 meV from 1.8–2.45 eV. The excitation power was kept at 20 μ W for all excitation energies. The excitation laser pulse was filtered with a sharp edge filter before being dispersed on a grating and detected with a charge-coupled device (CCD).

DFT calculations. The calculations were performed using density functional theory (DFT) as implemented in the Vienna ab-initio simulation package (VASP)^{53,54}. The projected augmented wave method has been used^{55,56}. The atomic and electronic structures were determined using the PBE functional. A plane wave basis with an energy cutoff of $E_{\text{cut}} = 500$ eV and a $(6 \times 6 \times 1)$ Monkhorst-Pack \mathbf{k} -point sampling has been used. The TMD layer has been modeled using a (9×9) supercell containing 242 atoms.

Data availability

The data that support the findings of this study are available from the corresponding author on reasonable request.

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Author contributions

J.K., U.W., M.Ka., J.J.F. and A.W.H. conceived and designed the experiments, M.L. and M.F. performed the DFT and independent boson model calculations, F.S., J.K. and S.R. prepared the samples, K.W. and T.T. provided high-quality hBN bulk crystals, J.K., E.M. and P.Z. performed helium ion exposure of samples, J.K., L.S., J.W., J.C. and K.M. performed the optical measurements, J.K. analyzed the data, R.S. and M.Kn. contributed interpreting the data, J.K. and A.W.H. wrote the manuscript with input from all coauthors.

Additional information

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